

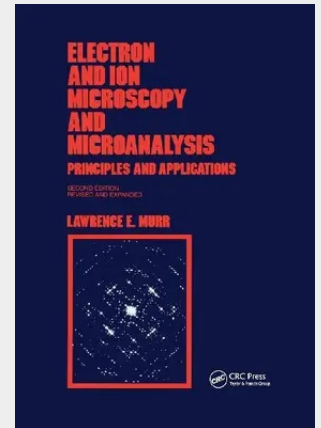
Murr

Electron and Ion Microscopy and Microanalysis

Principles and Applications, Second Edition,

The publication date of the first edition is not stated, but the new edition is apparently considerably revised and expanded. It was written to serve as a multi-purpose text at the senior or graduate level and as a reference for the practicing scientist or engineer. Readers should have a math backgr

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